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INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)		APPLICANT(S) Shinsuke OKADA et al.			
		FILING DATE May 24, 2006		GROUP	
		U.S. PATENT DOCUMENTS			
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/A.O.A./	13	YAMADA,T.; (2002); "Modeling of kink-shaped carbon-nanotube Schottky diode with gate bias modulation"; APPLIED PHYSICS LETTERS, 80(21); pp. 4027-4029			
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EXAMINER /Andrew O. Arena/				DATE CONSIDERED 07/01/2010	
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